onsemi

Small Signal BJT and MOSFET

30 V, 500 mA, PNP BJT with 20 V, 224 mA, N−Channel MOSFET

NSM3005NZ

Features
- These Devices are Pb−Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications
- Portable Devices

MARKING DIAGRAM

UDFN6
CASE 517AT
μCOOL ™

AE M∎

AE = Specific Device Code
M = Date Code
∎ = Pb−Free Package
(Note: Microdot may be in either location)
*Date Code orientation may vary depending upon manufacturing location.

Q1 MAXIMUM RATINGS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Collector−Emitter Voltage	V_{CEO}	30	V
Collector−Base Voltage	V_{CBO}	40	V
Emitter−Base Voltage	V_{EBO}	5.0	V
Collector Current	I_C	500	mA
Base Current	I_B	50	mA

Q2 MAXIMUM RATINGS (T_J = 25°C unless otherwise specified)

Parameter			Symbol	Value	Unit
Drain−to−Source Voltage			V_{DSS}	20	V
Gate−to−Source Voltage			V_{GS}	±8	V
Continuous Drain Current (Note 1)	Steady State	T_A = 25°C	I_D	224	mA
		T_A = 85°C		162	
	t ≤ 5 s	T_A = 25°C		241	
Pulsed Drain Current	T_p = 10 μs		I_{DM}	673	mA
Source Current (Body Diode)			I_S	120	mA

THERMAL CHARACTERISTICS

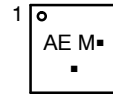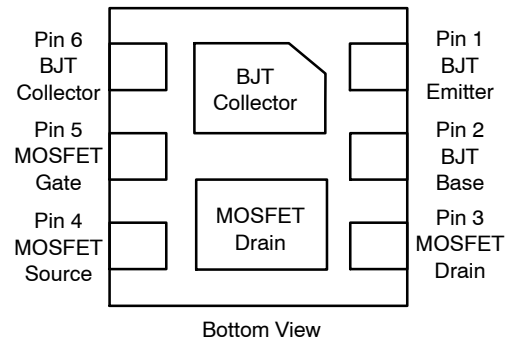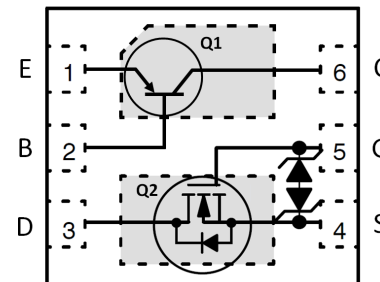| Parameter	Symbol	Value	Unit
Thermal Resistance Junction−to−Ambient (Note 1) Total Power Dissipation @ T_A = 25°C	$R_{\theta JA}$ P_D	245 0.8	°C/W W
Operating Junction and Storage Temperature	T_J, T_{STG}	−55 to 150	°C
Lead Temperature for Soldering Purposes (1/8″ from case for 10 s)	T_L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. Surface mounted on FR4 board using 1 in sq pad size (Cu. area = 1.127 in sq [1 oz] including traces).

PIN CONNECTIONS

Bottom View

ORDERING INFORMATION

Device	Package	Shipping†
NSM3005NZTAG	UDFN6 (Pb−Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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Q1 ELECTRICAL CHARACTERISTICS (T$_J$ = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Collector−Base Breakdown Voltage	V$_{(BR)CBO}$	I$_C$ = 100 μA	40	–	–	V
Collector−Emitter Breakdown Voltage	V$_{(BR)CEO}$	I$_C$ = 10 mA	30	–	–	V
Emitter−Base Breakdown Voltage	V$_{(BR)EBO}$	I$_E$ = 100 μA	5.0	–	–	V
Collector Cutoff Current	I$_{CBO}$	V$_{CB}$ = 25 V, I$_E$ = 0 A	–	–	1.0	μA
Emitter Cutoff Current	I$_{EBO}$	V$_{EB}$ = 5.0 V, I$_C$ = 0 A	–	–	10	μA
ON CHARACTERISTICS (Note 2)						
DC Current Gain	h$_{FE}$	V$_{CE}$ = 3.0 V, I$_C$ = 30 mA	20	–	100	
		V$_{CE}$ = 3.0 V, I$_C$ = 100 mA	20	–	100	
		V$_{CE}$ = 3.0 V, I$_C$ = 500 mA	20	–	100	
Collector−Emitter Saturation Voltage	V$_{CE(sat)}$	I$_C$ = 500 mA, I$_B$ = 50 mA	–	–	0.4	V
Base−Emitter Saturation Voltage	V$_{BE(sat)}$	I$_C$ = 500 mA, I$_B$ = 50 mA	–	–	1.1	V
Base−Emitter Turn−On Voltage	V$_{BE(on)}$	V$_{CE}$ = 1.0 V, I$_C$ = 500 mA	–	–	1.0	V

Q2 ELECTRICAL CHARACTERISTICS (T$_J$ = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain−to−Source Breakdown Voltage	V$_{(BR)DSS}$	V$_{GS}$ = 0 V, I$_D$ = 250 μA	20	–	–	V
Drain−to−Source Breakdown Voltage Temperature Coefficient	V$_{(BR)DSS}$/T$_J$	I$_D$ = −250 μA, ref to 25°C	–	19	–	mV/°C
Zero Gate Votlage Drain Current	I$_{DSS}$	V$_{GS}$ = 0 V, V$_{DS}$ = 16 V, T$_J$ = 25°C	–	–	1.0	μA
Gate−to−Source Leakage Current	I$_{GSS}$	V$_{DS}$ = 0 V, V$_{GS}$ = ±8.0 V	–	–	±2.0	μA
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage	V$_{GS(TH)}$	V$_{GS}$ = V$_{DS}$, I$_D$ = 250 μA	0.4	–	1.0	V
Negative Threshold Temperature Coefficient	V$_{GS(TH)}$/T$_J$	–	–	1.9	–	mV/°C
Drain−to−Source On Resistance	R$_{DS(ON)}$	V$_{GS}$ = 4.5 V, I$_D$ = 100 mA	–	0.65	1.4	Ω
		V$_{GS}$ = 2.5 V, I$_D$ = 50 mA	–	0.9	1.9	
		V$_{GS}$ = 1.8 V, I$_D$ = 20 mA	–	1.1	2.2	
		V$_{GS}$ = 1.5 V, I$_D$ = 10 mA		1.4	4.3	
Forward Transconductance	g$_{FS}$	V$_{DS}$ = 5.0 V, I$_D$ = 100 mA	–	0.56	–	S
CHARGES AND CAPACITANCES						
Input Capacitance	C$_{ISS}$	f = 1.0 MHz, V$_{GS}$ = 0 V, V$_{DS}$ = 15 V	–	15.8	–	pF
Output Capacitance	C$_{OSS}$		–	3.5	–	
Reverse Transfer Capacitance	C$_{RSS}$		–	2.4	–	
Total Gate Charge	Q$_{G(TOT)}$	V$_{GS}$ = 4.5 V, V$_{DS}$ = 15 V; I$_D$ = 200 mA	–	0.70	–	nC
Threshold Gate Charge	Q$_{G(TH)}$		–	0.05	–	
Gate−to−Source Charge	Q$_{GS}$		–	0.14	–	
Gate−to−Drain Charge	Q$_{GD}$		–	0.10	–	
SWITCHING CHARACTERISTICS, V$_{GS}$ = 4.5 V (Note 3)						
Turn−On Delay Time	t$_{d(ON)}$	V$_{GS}$ = 4.5 V, V$_{DD}$ = 15 V, I$_D$ = 200 mA, R$_G$ = 2 Ω	–	18	–	ns
Rise Time	t$_r$		–	35	–	
Turn−Off Delay Time	T$_{d(ON)}$		–	201	–	
Fall Time	t$_f$		–	110	–	
DRAIN−SOURCE DIODE CHARACTERISTICS						
Forward Diode Voltage	V$_{SD}$	V$_{GS}$ = 0 V, I$_S$ = 10 mA	–	0.55	1.0	V

2. Pulsed Condition: Pulse Width = 300 msec, Duty Cycle ≤ 2%.
3. Switching characteristics are independent of operating junction temperatures.

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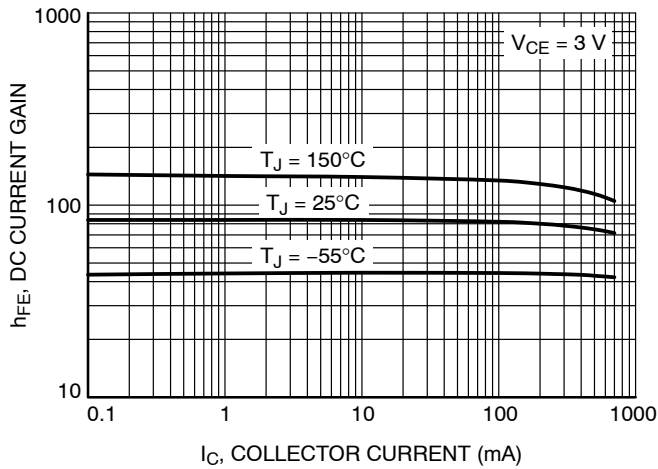## TYPICAL CHARACTERISTICS – Q1

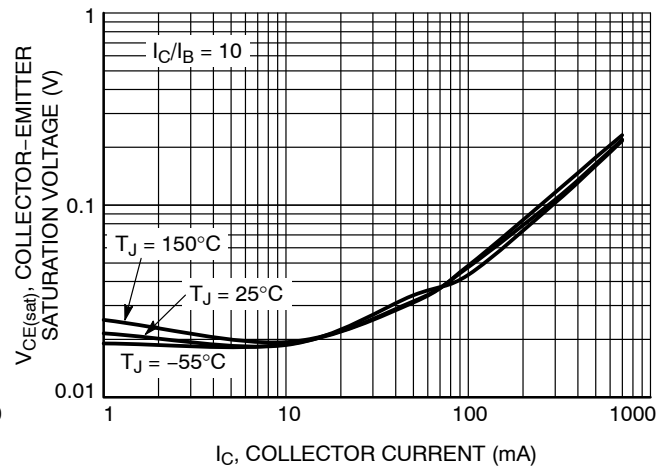**Figure 1. PNP DC Current Gain vs. Collector Current**
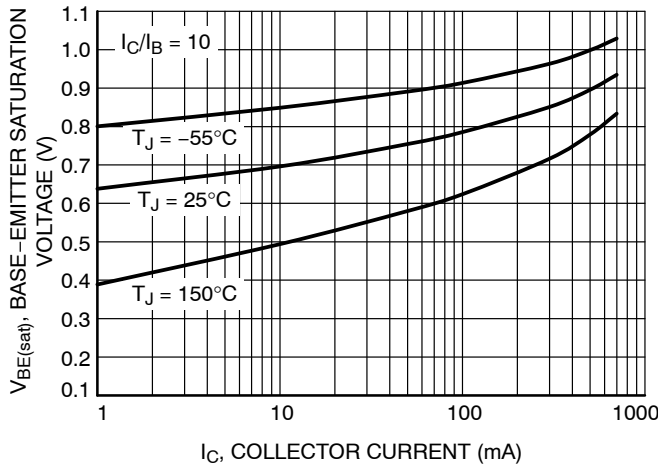
Figure 2. PNP VCE vs. IC
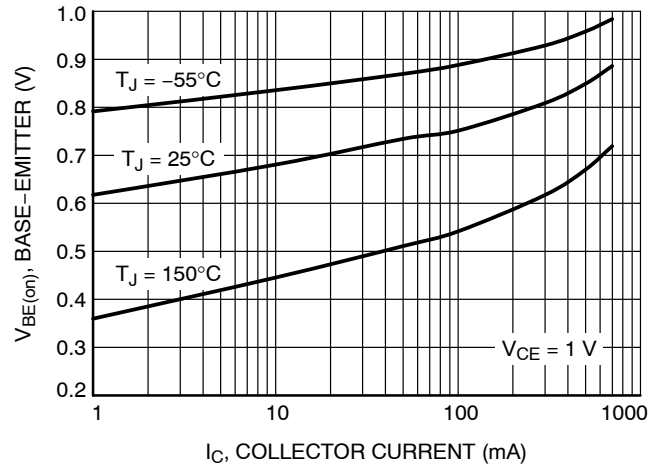
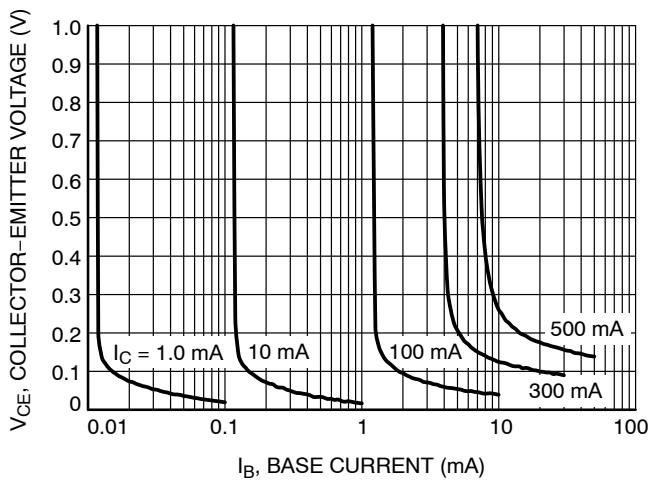**Figure 3. PNP VBE(sat) vs. IC**

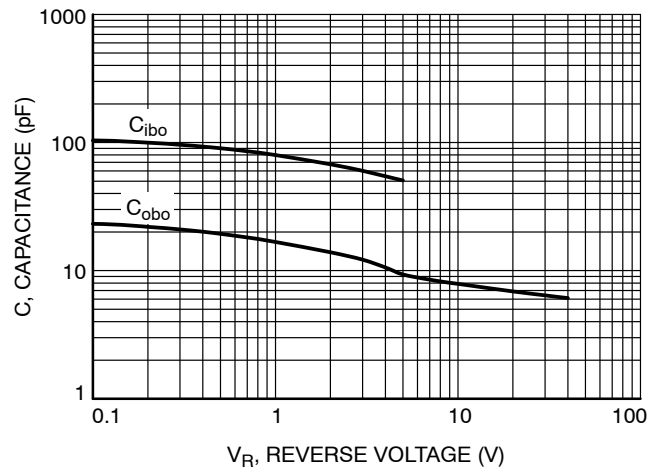**Figure 4. PNP VBE(on) vs. IC**

Figure 5. PNP VCE vs. IB

Figure 6. PNP Capacitance
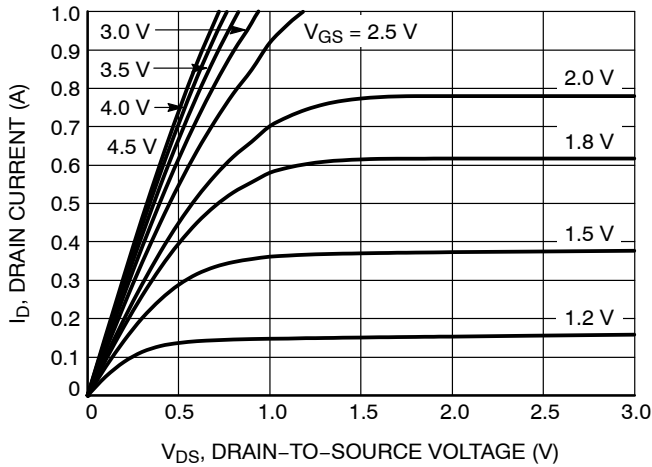
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TYPICAL CHARACTERISTICS – Q2

Figure 7. On−Region Characteristics
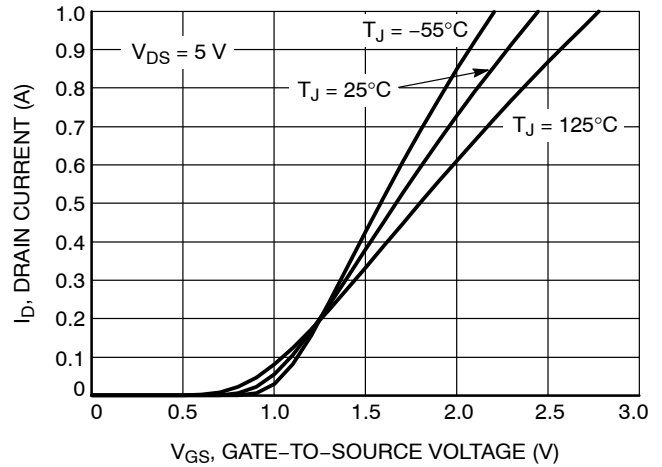
Figure 8. Transfer Characteristics
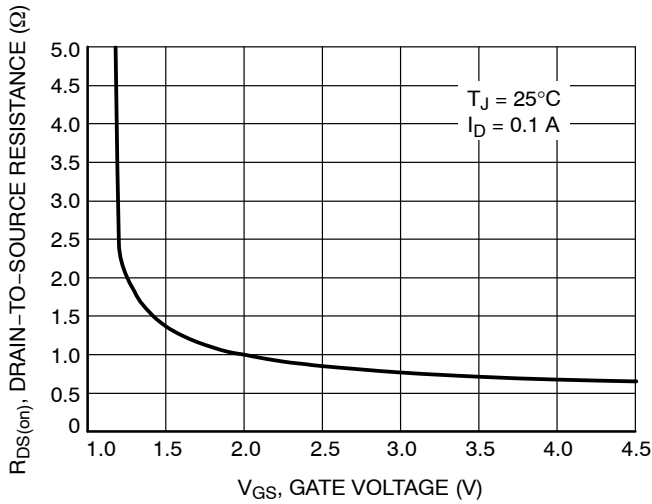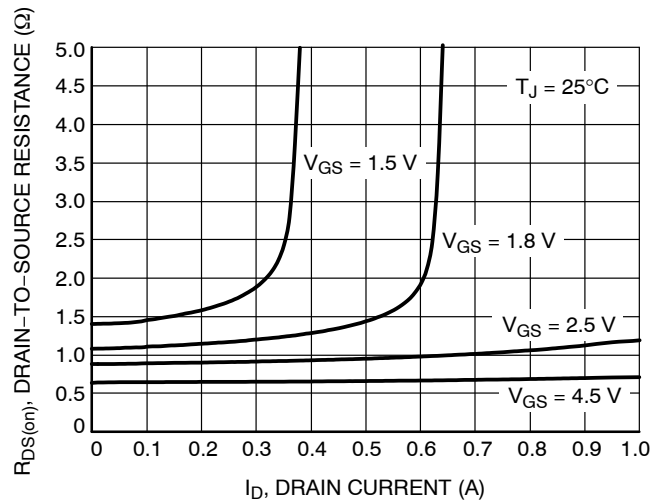

Figure 9. On−Resistance vs. Gate−to−Source Voltage

Figure 10. On−Resistance vs. Drain Current and Gate Voltage
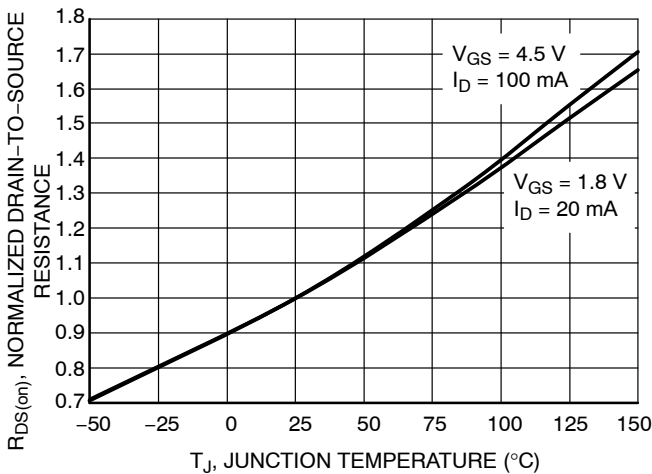
Figure 11. On−Resistance Variation with Temperature
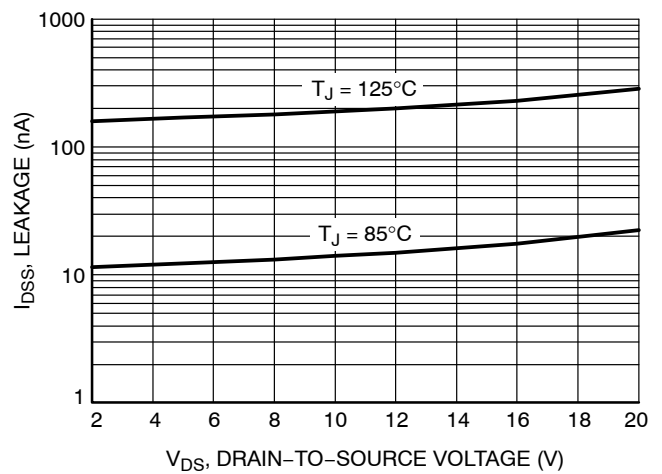
Figure 12. Drain−to−Source Leakage Current vs. Voltage

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TYPICAL CHARACTERISTICS – Q2
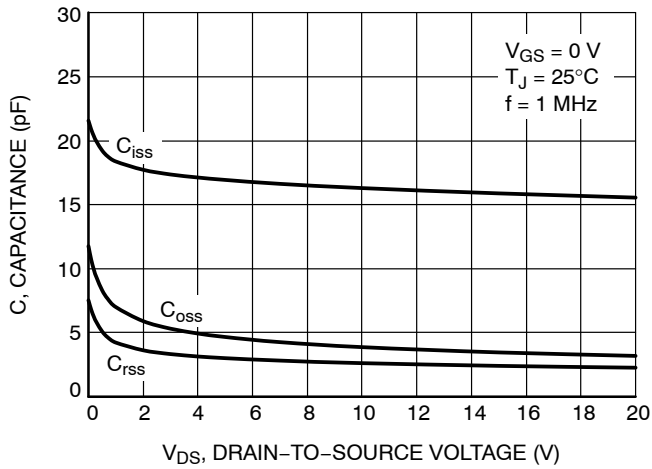
Figure 13. Capacitance Variation
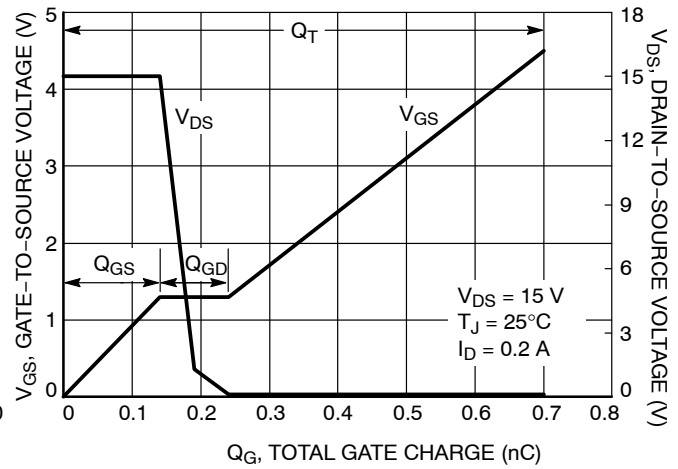
Figure 14. Gate−to−Source and Drain−to−Source Voltage vs. Total Charge
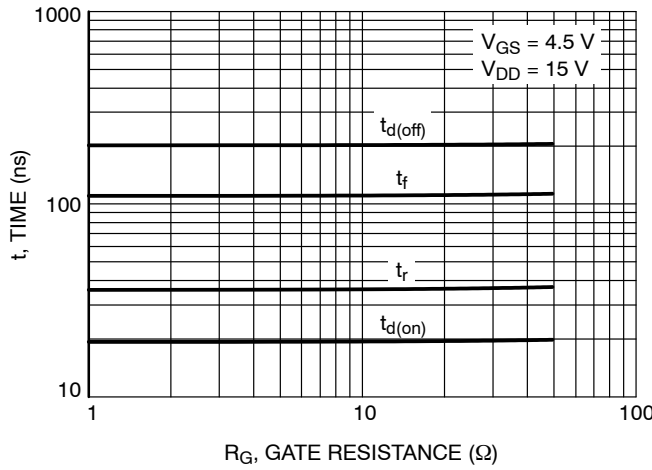
Figure 15. Resistive Switching Time Variation vs. Gate Resistance
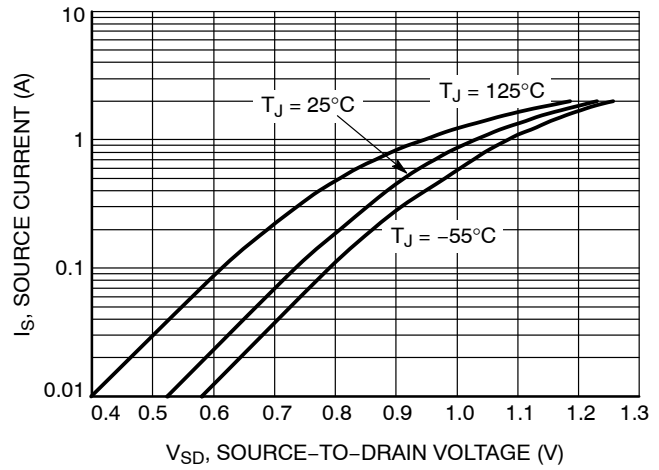
Figure 16. Diode Forward Voltage vs. Current
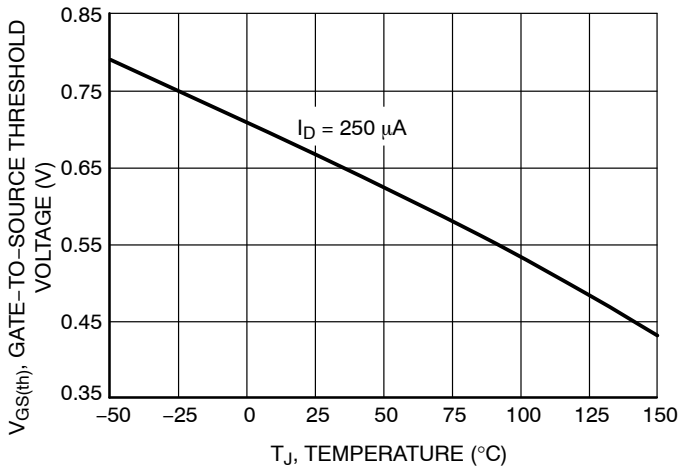
Figure 17. Threshold Voltage

μCOOL is a trademark of Semiconductor Components Industries, LLC.
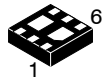
SCALE 4:1

UDFN6 1.6x1.6, 0.5P
CASE 517AT
ISSUE O

DATE 02 SEP 2008
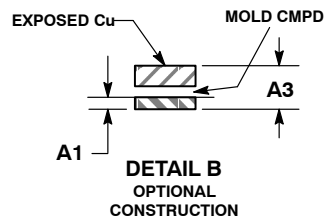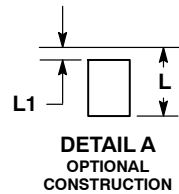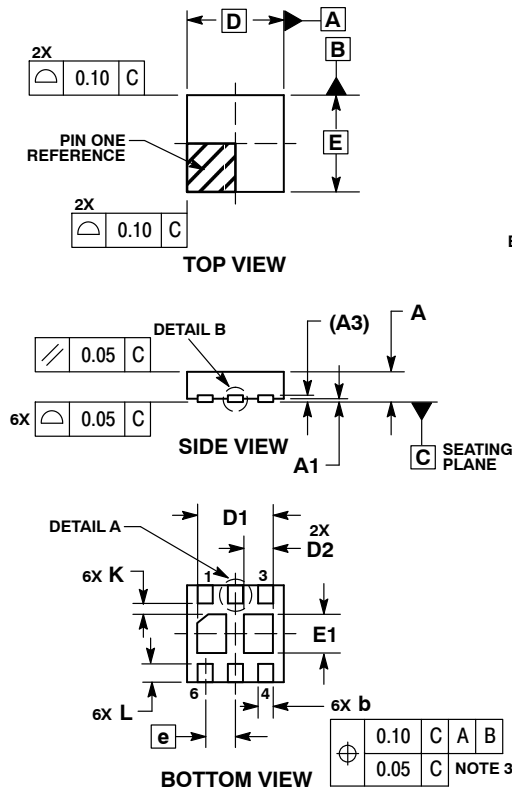
NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM TERMINAL.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

TOP VIEW

2X [⌴ 0.10 C]

PIN ONE REFERENCE

2X [⌴ 0.10 C]

DETAIL A
OPTIONAL CONSTRUCTION

SIDE VIEW

[∥ 0.05 C]

DETAIL B

6X [⌴ 0.05 C]

C SEATING PLANE

EXPOSED Cu

MOLD CMPD

DETAIL B
OPTIONAL CONSTRUCTION

DIM	MILLIMETERS	
	MIN	MAX
A	0.45	0.55
A1	0.00	0.05
A3	0.13 REF	
b	0.20	0.30
D	1.60 BSC	
E	1.60 BSC	
e	0.50 BSC	
D1	1.14	1.34
D2	0.38	0.58
E1	0.54	0.74
K	0.20	---
L	0.15	0.35
L1	---	0.10

BOTTOM VIEW

DETAIL A

6X K

6X L

6X b

[⊕ 0.10 C A B]
[0.05 C NOTE 3]

GENERIC MARKING DIAGRAM*

XX M▪
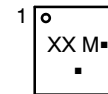
XX = Specific Device Code
M = Date Code
▪ = Pb−Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

SOLDERMASK DEFINED MOUNTING FOOTPRINT*

1.34
2X 0.58
6X 0.48
0.74 1.90
0.50 PITCH
6X 0.32
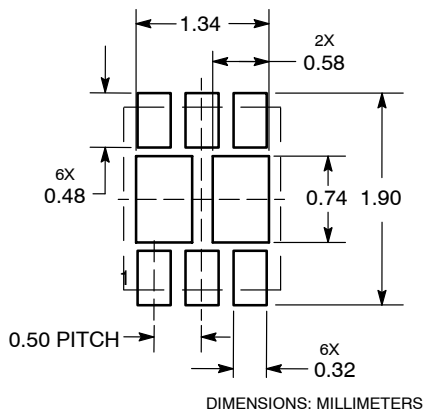
DIMENSIONS: MILLIMETERS

*For additional information on our Pb−Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	UDFN6, 1.6X1.6, 0.5P		PAGE 1 OF 1

ADDITIONAL INFORMATION

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